

Notice of References Cited	Application/Control No. 10/602,744	Applicant(s)/Patent Under Reexamination BAEK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	11-326621	11-1999	Japan	Aoki et al.	G02B 005/20
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NON-PATENT DOCUMENTS

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